#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney Docket No.: VISH-8728

Inventor(s): Deva N. Pattanayak and Robert Xu

Serial No.: Group Art Unit:

Filed: 12/02/03 Examiner:

Title: CLOSED CELL TRENCH METAL-OXIDE-SEMICONDUCTOR FIELD

EFFECT TRANSISTOR

Commissioner of Patents P. O. Box 1450 Alexandria, VA 22313-1450

Sir:

Information Disclosure Statement Submitted Pursuant to 37 C.F.R. 1.97(b)

The citations referenced herein, copies attached, may be material to the examination of the above-identified application and are, therefore, submitted in compliance with the duty of disclosure as defined in 37 C.F.R. 1.56. The Examiner is requested to make these citations of official record in the application.

This Information Disclosure Statement submitted in accordance with 37 C.F.R. 1.97(b) is not to be construed as a representation that a search has been made, that additional items material to the examination of this application do not exist, or that any one or more of these citations constitute prior art under 35 U.S.C. 102.

The Examiner's attention is respectfully directed to the following U.S. Patents:

<u>Pat. No.</u> <u>Pat. Title</u> <u>Grant Date</u> 5,929,481 HIGH DENSITY TRENCH DMOS TRANSISTOR WITH TRENCH BOTTOM IMPLANT 07/27/99

Please direct all correspondence concerning the above-identified application to the following address:

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Respectfully submitted,

Date: December 7, 2003

Reg. No. 46,274

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## Form 1449

## **U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
	Α	5,929,481	07/27/99	Hshieh, et al.	257	328	11/04/97
	В						
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Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
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#### Other Documents

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Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication			
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Examiner	•	Date Considered			

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.